## Notice of References Cited

Application/Control No. 10/796,688	Reexamination	Applicant(s)/Patent Under Reexamination WARNER ET AL.		
Examiner	Art Unit			
Frederick C. Nicolas	3754	Page 1 of 1		

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,789,705	09-2004	Drew, Frank M.	222/174
	В	US-3,856,209	12-1974	Hickson, John D.	239/532
	C	US-3,485,206	12-1969	SMRT THOMAS J	118/305
	D	US-6,390,336	05-2002	Orozco, Domingo	222/162
	E	US-4,099,482	07-1978	Smrt, Thomas J.	118/712
	F	US-4,886,191	12-1989	Yoshitomi, Shingo	222/174
	G	US-4,089,440	05-1978	Lee, Edward	222/174
	H	US-3,039,657	06-1962	MEUWLY JAMES A	222/174
	-1	US-3,017,056	01-1962	BISHOP CHARLES J	222/164
	J	US-5,307,959	05-1994	Bedore et al.	222/174
	К	US-3,861,566	01-1975	Wentzell, James G.	222/174
	L	US-3,716,195	02-1973	Silva, George E.	239/375
	М	US-		,	

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N			,	:	
	0	9				*
	Р					
	Q				•	
	R					
	S					
	Т				,	

## NON-PATENT DOCUMENTS

*		nt Pages)			
	U				
	V				
	w				
	х		-		

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.